

Notice of References Cited

Application/Control No.

10/821,159

Applicant(s)/Patent Under
Reexamination
GARROW ET AL.

Examiner

YONAS BAYOU

Art Unit

2434

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,046,263	05-2006	Abbott et al.	715/740
*	B	US-2002/0151992	10-2002	Hoffberg et al.	700/83
*	C	US-5,918,222	06-1999	Fukui et al.	707/1
*	D	US-6,747,675	06-2004	Abbott et al.	715/740
*	E	US-6,640,145	10-2003	Hoffberg et al.	700/83
*	F	US-6,400,996	06-2002	Hoffberg et al.	700/83
*	G	US-2004/0259494	12-2004	Mazar, Scott T.	455/001
*	H	US-6,339,774	01-2002	Nakayama et al.	707/10
*	I	US-2002/0183646	12-2002	Stivorc et al.	600/549
*	J	US-2002/0011958	01-2002	Ogawa et al.	343/761
*	K	US-6,605,038	08-2003	Teller et al.	600/300
*	L	US-6,160,986	12-2000	Gabai et al.	434/308
*	M	US-5,535,063	07-1996	Lamming, Michael G.	360/4

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.